







CSD83325L SLPS494C - NOVEMBER 2014 - REVISED NOVEMBER 2023

CSD83325L 12-V Dual N-Channel NexFET™ Power MOSFET

1 Features

- Common drain configuration
- Low-on resistance
- Small footprint of 2.2 mm × 1.15 mm
- Lead free
- RoHS compliant
- Halogen free
- Gate ESD protection

2 Applications

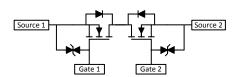
- Battery management
- **Battery protection**

3 Description

This 12-V, $9.9\text{-m}\Omega$, $2.2\text{-mm} \times 1.15\text{-mm}$ LGA Dual NexFET™ power MOSFET is designed to minimize resistance and gate charge in a small footprint. Its small footprint and common drain configuration make the device ideal for battery pack applications in small handheld devices.



Top View



Configuration 30 T_C = 25°C, I_D = 5 A T_C = 125°C, I_D = 5 A $R_{S1S2(on)}$ - On-State Resistance $(m\Omega)$ 27 24 21 18 15 12 9 6 0 3 4 5 6 7 V_{GS} - Gate-to-Source Voltage (V) 0 10

R_{DS(on)} vs V_{GS}

Product Summary

T _A = 25°C		TYPICAL V	UNIT	
V _{S1S2}	Source-to-Source Voltage	12	V	
Qg	Gate Charge Total (4.5 V)	8.4	nC	
Q _{gd}	Gate Charge Gate-to-Drain	1.9	nC	
R _{S1S2(on)}		V _{GS} = 2.5 V	17.5	mΩ
	Source-to-Source On Resistance	V _{GS} = 3.8 V	10.9	mΩ
		V _{GS} = 4.5 V 9.9		mΩ
V _{GS(th)}	Threshold Voltage	1.0	V	

Device Information⁽¹⁾

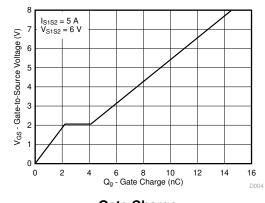
DEVICE	QTY	MEDIA	PACKAGE	SHIP
CSD83325L	3000		2.20-mm × 1.15-mm	Tape
CSD83325LT	250	7-Inch Reel	Land Grid Array (LGA) Package	and Reel

For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 25	s°C	VALUE	UNIT							
V _{S1S2}	Source-to-Source Voltage	12	V							
V _{GS}	Gate-to-Source Voltage	±10	V							
I _S	Continuous Source Current ⁽¹⁾	8	Α							
I _{SM}	Pulsed Source Current ⁽²⁾	52	Α							
P_D	Power Dissipation	2.3	W							
V _(ESD)	Human-Body Model (HBM)	2000	V							
T _J , T _{stg}	Operating Junction Temperature, Storage Temperature	-55 to 150	°C							

- Device operating at a temperature of 105°C. (1)
- Typical min Cu $R_{\theta JA}$ = 150°C/W, pulse duration ≤ 100 µs, duty (2) cycle ≤ 1%.



Gate Charge



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4 Specifications

4.1 Electrical Characteristics

 $T_A = 25^{\circ}C$ (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC C	CHARACTERISTICS					
BV _{S1S2}	Source-to-source voltage	V _{GS} = 0 V, I _S = 250 μA	12			V
I _{S1S2}	Source-to-source leakage current	V _{GS} = 0 V, V _{S1S2} = 9.6 V			1.0	μΑ
I _{GSS}	Gate-to-source leakage current	V _{S1S2} = 0 V, V _{GS} = 10 V			10	μA
V _{GS(th)}	Gate-to-source threshold voltage	V _{S1S2} = V _{GS} , I _S = 250 μA	0.7	1.0	1.4	V
		V _{GS} = 2.5 V, I _S = 5 A	12.0	17.5	23.0	mΩ
R _{S1S2(on)}	Source-to-source on resistance	V _{GS} = 3.8 V, I _S = 5 A	8.8	10.9	13.0	mΩ
		V _{GS} = 4.5 V, I _S = 5 A	7.9	9.9	11.9	mΩ
9 _{fs}	Transconductance	V _{S1S2} = 1.2 V, I _S = 5 A		36		S
DYNAMI	C CHARACTERISTICS ⁽¹⁾					
C _{iss}	Input capacitance			902	1170	pF
C _{oss}	Output capacitance	$V_{GS} = 0 \text{ V}, V_{S1S2} = 6 \text{ V}, f = 1 \text{ MHz}$		187	243	pF
C _{rss}	Reverse transfer capacitance			111	144	pF
Qg	Gate charge total (4.5 V)			8.4	10.9	nC
Q _{gd}	Gate charge gate-to-drain	V -6VI-5A		1.9		nC
Q _{gs}	Gate charge gate-to-source	$V_{S1S2} = 6 \text{ V}, I_S = 5 \text{ A}$		2.2		nC
Q _{g(th)}	Gate charge at V _{th}			0.6		nC
Q _{oss}	Output charge	V _{S1S2} = 6 V, V _{GS} = 0 V		2.9		nC
t _{d(on)}	Turnon delay time			205		ns
t _r	Rise time	V _{S1S2} = 6 V, V _{GS} = 4.5 V,		353		ns
t _{d(off)}	Turnoff delay time	I _{S1S2} = 5 A, R _G = 0 Ω		711		ns
t _f	Fall time			589		ns
DIODE C	HARACTERISTICS		1			
V _{F(S-S)}	Source-to-source diode forward voltage	I _{SS} = 5 A, V _{G1S1} = 0 V, V _{G2S2} = 4.5 V		0.79	1.0	V

⁽¹⁾ Dynamic characteristics values specified are per single FET.

4.2 Thermal Information

T_A = 25°C (unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
В	Junction-to-ambient thermal resistance ⁽¹⁾		150		°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽²⁾		55		C/VV

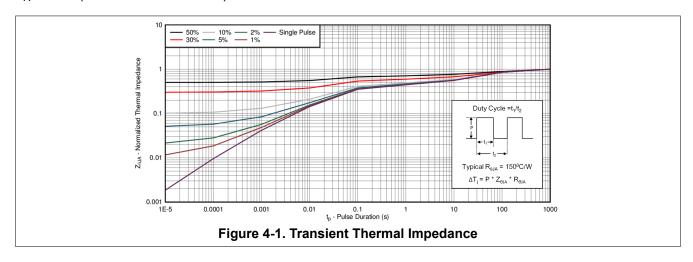
⁽¹⁾ Device mounted on FR4 material with minimum Cu mounting area.

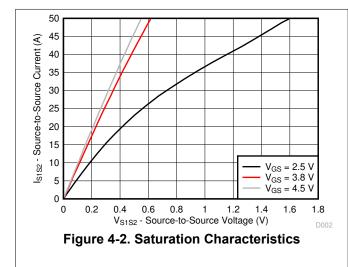
⁽²⁾ Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.

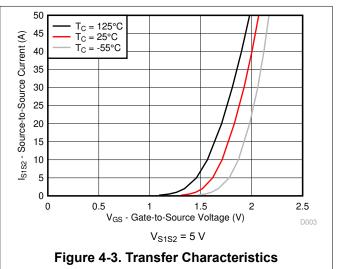


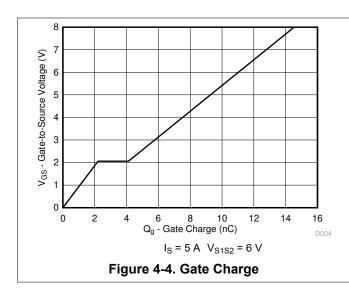
4.3 Typical MOSFET Characteristics

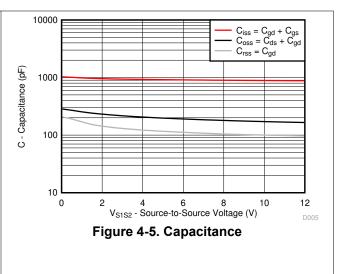
 $T_A = 25$ °C (unless otherwise stated)

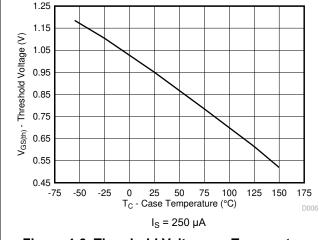












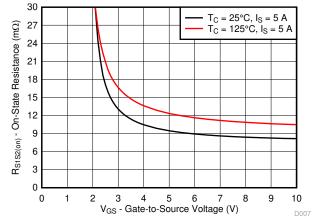
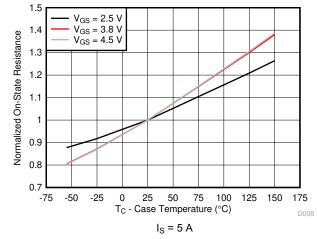


Figure 4-6. Threshold Voltage vs Temperature

Figure 4-7. On-State Source-to-Source Resistance vs Gate-to-Source Voltage



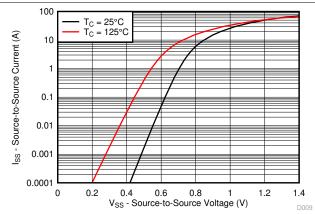
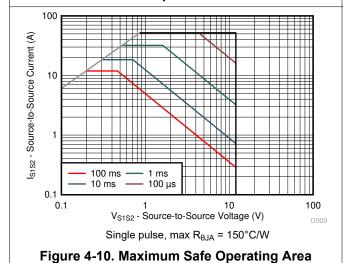


Figure 4-8. Normalized On-State Resistance vs
Temperature

Figure 4-9. Typical Diode Forward Voltage



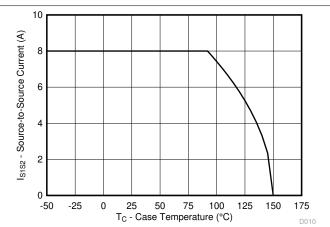


Figure 4-11. Maximum Source Current vs
Temperature

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5 Device and Documentation Support

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5.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

5.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

6 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (February 2017) to Revision C (November 2023)	Page
Updated Threshold Voltage GS(th) from 0.95 V to 1.0 V	1
• Updated the numbering format for tables, figures, and cross-references throughout the docum	
• Updated Source-to-source on resistance VGS = 2.5 V from 14 m Ω to 12 m Ω	
Updated Gate-to-source threshold voltage from 0.75 V min, 0.95 V typ, 1.25 V max to 0.7 V m 1.4 V max	
Changes from Revision A (January 2016) to Revision B (February 2017)	Page
Added Diode Characteristics (V _{F(S-S)}) in the <i>Electrical Characteristics</i> table	3
Added Figure 4-9 to Typical MOSFET Characteristics section	4
Changes from Revision * (November 2014) to Revision A (January 2016)	Page
Improved graph setup for readability	4

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7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD83325L	ACTIVE	PICOSTAR	YJE	6	3000	RoHS & Green	NIAU	Level-1-260C-UNLIM		83325L	Samples
CSD83325LT	ACTIVE	PICOSTAR	YJE	6	250	RoHS & Green	NIAU	Level-1-260C-UNLIM	-55 to 150	83325L	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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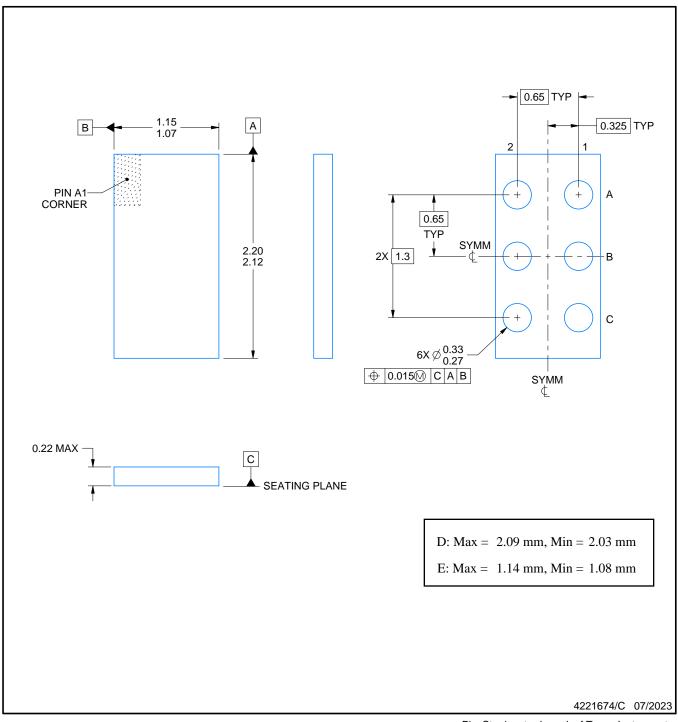


PACKAGE OPTION ADDENDUM

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PicoStar



NOTES:

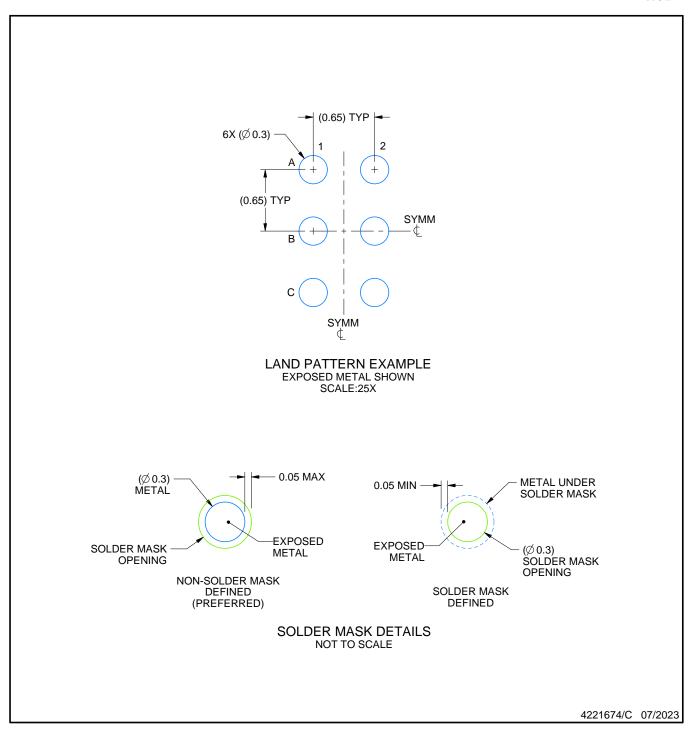
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- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.



PicoStar

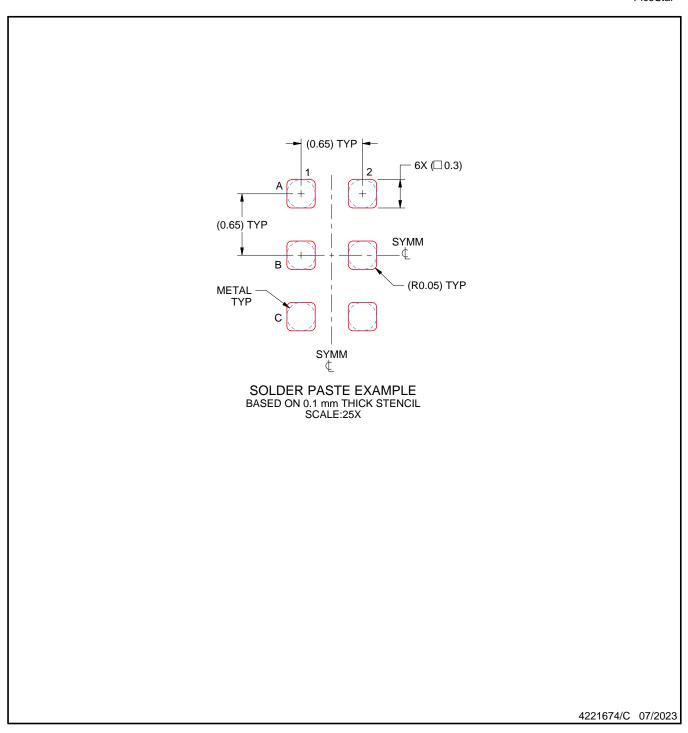


NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



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NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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